

OptiMOS[™] P3 Power-Transistor

Features

- single P-Channel in S3O8
- Qualified according JEDEC¹⁾ for target applications
- 150 °C operating temperature
- $V_{\rm GS}$ =25 V, specially suited for notebook applications
- Pb-free; RoHS compliant
- · ESD protected
- applications: battery management, load switching
- Halogen-free according to IEC61249-2-21

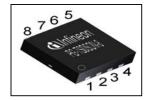


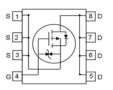


Product Summary

V _{DS}	-30	V
R _{DS(on),max}	12	mΩ
I _D	-40	Α

PG-TSDSON-8





Туре	Package	Marking	Lead free	Halogen free	Packing
BSZ120P03NS3E G	PG-TSDSON-8	120P3NE	Yes	Yes	non-dry

Maximum ratings, at T_i =25 °C, unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Continuous drain current	I _D	T _C =25 °C	-40.0	А
		T _C =70 °C	-40	1
		T _A =25 °C ²⁾	-11.0	
Pulsed drain current	I _{D,pulse}	T _C =25 °C ³⁾	-160	
Avalanche energy, single pulse	E _{AS}	$I_{\rm D}$ =-20 A, $R_{\rm GS}$ =25 Ω	73	mJ
Gate source voltage	V _{GS}		±25	V
Power dissipation	P tot	T _A =25 °C	52	W
		T _A =25 °C ²⁾	2.1	
Operating and storage temperature	$T_{\rm j}$, $T_{\rm stg}$		-55 150	°C
ESD class		JESD22-A114 HBM	class 2 (> 2 kV)	
Soldering temperature			260	°C
IEC climatic category; DIN IEC 68-1			55/150/56	

¹⁾ J-STD20 and JESD22



Parameter	Symbol	Conditions		Values		Unit
			min.	typ.	max.	
Thermal characteristics						
Thermal resistance, junction - case	$R_{ m thJC}$		-	-	2.4	K/W
Thermal resistance, junction - ambient	$R_{ m thJA}$	6 cm ² cooling area ²⁾	-	1	60	

Electrical characteristics, at $T_{\rm j}$ =25 °C, unless otherwise specified

Static characteristics

Drain-source breakdown voltage	V _{(BR)DSS}	V _{GS} =0 V, I _D =-250μA	-30	-	-	V
Gate threshold voltage	$V_{GS(th)}$	V _{DS} =V _{GS} , I _D =-73 μA	-3.1	-2.5	-1.9	
Zero gate voltage drain current	I _{DSS}	V _{DS} =-30 V, V _{GS} =0 V, T _j =25 °C	-	-	-1	μΑ
		V _{DS} =-30 V, V _{GS} =0 V, T _j =125 °C	1	-	-100	
Gate-source leakage current	I _{GSS}	$V_{\rm GS}$ =-25 V, $V_{\rm DS}$ =0 V	1	1	-10	μΑ
Drain-source on-state resistance	R _{DS(on)}	V _{GS} =-6 V, I _D =-20 A	-	12.0	20.0	mΩ
		V _{GS} =-10 V, I _D =-20 A	-	9.0	12.0	
Gate resistance	R _G		1	2.2	-	Ω
Transconductance	g _{fs}	$ V_{\rm DS} > 2 I_{\rm D} R_{\rm DS(on)max},$ $I_{\rm D} = -20 \text{ A}$	22	36	-	S

 $^{^{2)}}$ Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm² (one layer, 70 μ m thick) copper area for drain connection. PCB is vertical in still air.

³⁾ See Fig. 3 for more detailed information



Parameter	Symbol	Conditions		Values	Values	
			min.	typ.	max.	
Dynamic characteristics						
Input capacitance	C iss		-	2240	3360	pF
Output capacitance	C oss	V _{GS} =0 V, V _{DS} =-15 V, f=1 MHz	-	1090	1635	
Reverse transfer capacitance	C _{rss}]	-	74	111	
Turn-on delay time	t _{d(on)}		-	13	20	ns
Rise time	t _r	V _{DD} =-15 V, V _{GS} =- 10 V, I _D =-20 A,	-	11	17	
Turn-off delay time	t _{d(off)}	$R_{\rm G}$ =6 Ω	-	23	35	
Fall time	t _f]	-	5	8	
Gate Charge Characteristics ³⁾						
Gate to source charge	Q _{gs}		-	11	17	nC
Gate charge at threshold	Q _{g(th)}]	-	4	6	
Gate to drain charge	Q _{gd}	V _{DD} =-15 V, I _D =20 A,	-	5	8	
Switching charge	Q sw	V _{GS} =0 to -10 V	-	13	20	
Gate charge total	Qg]	-	30	45	
Gate plateau voltage	V _{plateau}]	-	4.6	-	V
Output charge	Q _{oss}	V _{DD} =-15 V, V _{GS} =0 V	-	25	38	nC
Reverse Diode	•	•		-	-	•
Diode continous forward current	Is	- T _C =25 °C	-	-	40	Α
Diode pulse current	I _{S,pulse}	- / _C =25 C	-	-	160	
Diode forward voltage	V _{SD}	V _{GS} =0 V, I _F =-20 A, T _j =25 °C	-	-	-1.1	V
Reverse recovery time	t rr	V_R =15 V, I_F = $ I_S $, di_F/dt =100 A/ μ s	-	47	-	ns
Reverse recovery charge	Q _{rr}	1	-	55	-	nC

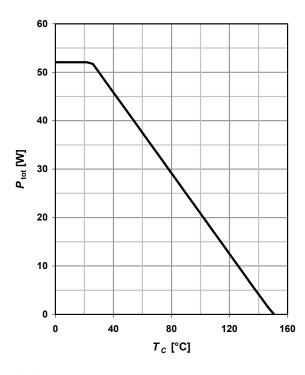


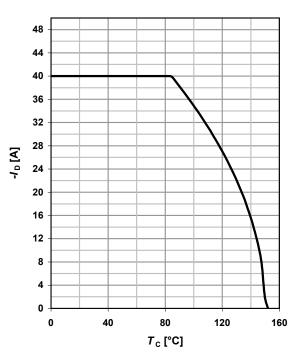
1 Power dissipation

P_{tot} =f(T_{C}); t_{p} ≤10 s

2 Drain current

$$I_{D} = f(T_{C}); |V_{GS}| \ge 10 \text{ V}; t_{p} \le 10 \text{ s}$$





3 Safe operating area

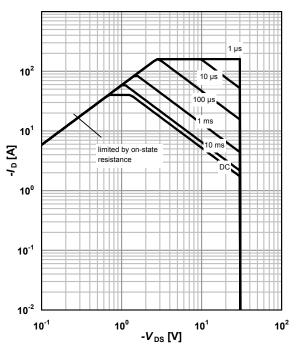
$$I_D = f(V_{DS}); T_C = 25 \text{ °C}^{1)}; D = 0$$

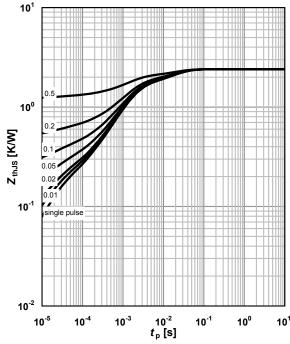
parameter: $t_{\rm p}$

4 Max. transient thermal impedance

$$Z_{thJS}$$
=f(t_p)

parameter: $D = t_p/T$



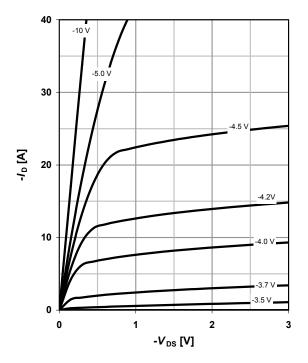




5 Typ. output characteristics

 $I_D = f(V_{DS}); T_j = 25 °C$

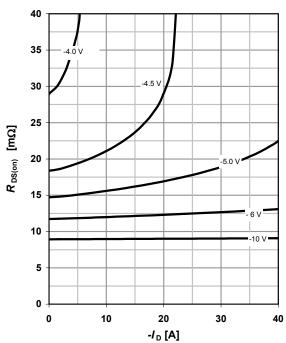
parameter: $V_{\rm GS}$



6 Typ. drain-source on resistance

 $R_{DS(on)}=f(I_D); T_j=25 \text{ }^{\circ}\text{C}$

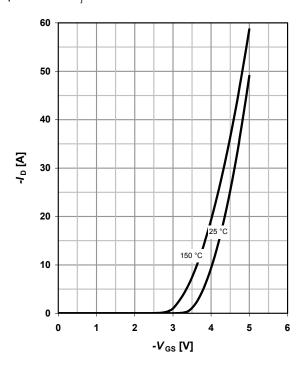
parameter: $V_{\rm GS}$



7 Typ. transfer characteristics

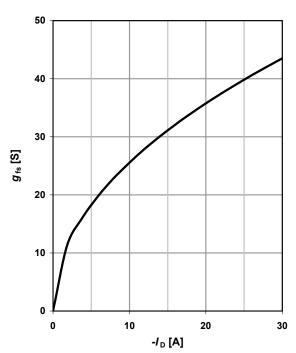
 I_{D} =f(V_{GS}); $|V_{DS}|$ >2 $|I_{D}|R_{DS(on)max}$

parameter: $T_{\rm j}$



8 Typ. forward transconductance

$$g_{fs}$$
=f(I_D); T_j =25 °C





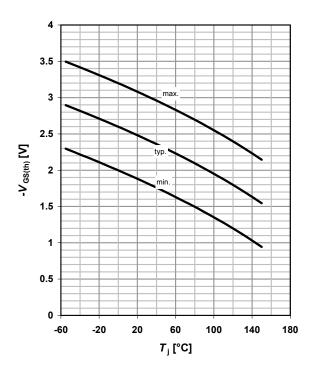
9 Drain-source on-state resistance

$$R_{DS(on)}$$
=f(T_j); I_D =-20 A; V_{GS} =-10 V

20 18 16 14 R_{DS(on)} [mΩ] 10 8 6 4 -60 -20 20 60 100 140 180 T_j [°C]

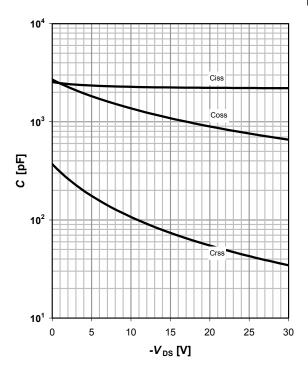
10 Typ. gate threshold voltage

$$V_{\rm GS(th)}$$
=f($T_{\rm j}$); $V_{\rm GS}$ = $V_{\rm DS}$; $I_{\rm D}$ =-73 μA



11 Typ. capacitances

 $C = f(V_{DS}); V_{GS} = 0 V; f = 1 MHz$



12 Forward characteristics of reverse diode

$$I_F = f(V_{SD})$$

parameter: T_j

100 10 150 °C, typ 150 °C, typ 150 °C, typ 150 °C, 98% 0.1 0.1 0 0.5 1 1.5



13 Avalanche characteristics

 I_{AS} =f(t_{AV}); R_{GS} =25 Ω

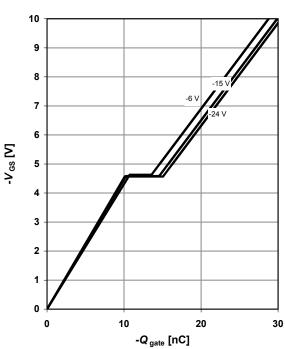
parameter: $T_{j(start)}$

 $t_{\mathsf{AV}}\,[\mu\mathsf{s}]$

14 Typ. gate charge

 $V_{\rm GS}$ =f($Q_{\rm gate}$); $I_{\rm D}$ =-20 A pulsed

parameter: V_{DD}



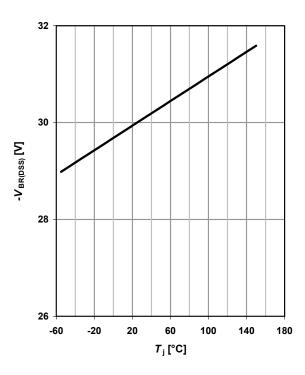
15 Drain-source breakdown voltage

10¹

 $V_{BR(DSS)}$ = $f(T_i)$; I_D =-250 μ A

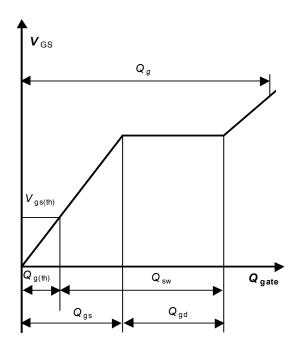
10⁰

10⁰



16 Gate charge waveforms

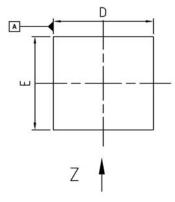
10³

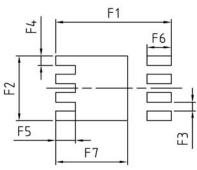


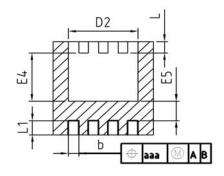


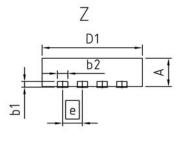
Package Outline

PG-TSDSON-8

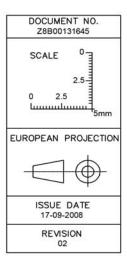








DIM	MILLIM	ETERS	INCHES		
им п	MIN	MAX	MIN	MAX	
Α	0.90	1.10	0.035	0.043	
ь	0.24	0.44	0.009	0.017	
ь1	0.10	0.30	0.004	0.012	
b2	0.20	0.44	0.008	0.017	
D=D1	3.20	3.40	0.126	0.134	
D2	2.15	2.45	0.085	0.096	
E	3.20	3.40	0.126	0.134	
E4	1.60	1.81	0.063	0.071	
E5	0.59	0.86	0.023	0.034	
е	0.65		0.026		
N		8	8		
L	0.30	0.56	0.012	0.022	
L1	0.33	0.60	0.013	0.024	
aaa	0.3	25	0.0	010	
F1	3.8	80	0.1	150	
F2	2.3	29	0.0	90	
F3	0.31		0.012		
F4	0.34		0.013		
F5	0.65		0.026		
F6	0.80		0.031		
F7	2.3	36	0.0	093	



Dimensions in mm



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